11.5.3 Use of lateral shear interferometer to measure the OTF

H. H. Hopkins was the first to show that a lateral shearing interferometer can be used to measure the OTF of an optical system. (Ref: H. H. Hopkins, Opt. Acta 2, 23 (1955).)

The one-dimensional OTF of an optical system $H[f_x]$ is given by the autocorrelation of the pupil function

$$
H[f_x] = \frac{1}{c} \int_{-\infty}^{\infty} \int_{-\infty}^{\infty} P\left[x + \frac{s}{2}, y\right] P^{*}\left[x - \frac{s}{2}, y\right] dx dy
$$

If z_i is the image distance, D is the pupil diameter, and λ is the wavelength

$$
\mathtt{f}_{\mathtt{x}} = \frac{\mathtt{s}}{\lambda \mathtt{z}_{\mathtt{i}}} = \frac{\mathtt{s}}{\mathtt{D}} \frac{1}{\lambda} \frac{\mathtt{D}}{\mathtt{z}_{\mathtt{i}}} = \frac{\mathtt{s}}{\mathtt{D}} \frac{1}{\lambda \mathtt{f}^{\mathtt{H}}}
$$

For simplicity let the two interfering beams in a lateral shear interferometer have the same intensity. Let δ be the phase difference between the two sheared interfering wavefronts due to path difference in the interferometer. Generally δ is made to vary linearly with time, i.e. $\delta = \omega t + \phi_o$.

Then the total flux in the interference pattern is

$$
F[\delta, s] = \int_{-\infty}^{\infty} \int_{-\infty}^{\infty} Abs \left[P \left[x + \frac{s}{2}, y \right] + P \left[x - \frac{s}{2}, y \right] e^{-i\delta} \right]^2 dx dy
$$

\n
$$
= 2 \int \int Abs \left[P \left[x + \frac{s}{2}, y \right] \right]^2 dx dy +
$$

\n
$$
\int \int P \left[x + \frac{s}{2}, y \right] P^* \left[x - \frac{s}{2}, y \right] e^{i\delta} dx dy + \text{complex conjugate}
$$

\n
$$
= 2 c (1 + Abs [H [f_x]] Cos [\delta - \theta [f_x]])
$$

2c is the average amount of flux in the two interfering wavefronts.